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(12) **United States Design Patent**  
**Markovsky et al.**

(10) **Patent No.:** **US D694,425 S**  
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(54) **RECOGNITION TEST STRIP**  
(75) Inventors: **Robert J. Markovsky**, Brentwood, NH  
(US); **Stanley E. Charm**, Boston, MA  
(US); **Richard T. Skiffington**, N.  
Reading, MA (US)  
(73) Assignee: **Charm Sciences, Inc.**, Lawrence, MA  
(US)

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(\*\*) Term: **14 Years**

\* cited by examiner

(21) Appl. No.: **29/408,364**

*Primary Examiner* — Anhdao Doan

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(74) *Attorney, Agent, or Firm* — MacCord Mason PLLC

(51) **LOC (9) Cl.** ..... **24-01**

(57) **CLAIM**

(52) **U.S. Cl.**

The ornamental design for a recognition test strip, as shown and described.

USPC ..... **D24/225**

**DESCRIPTION**

(58) **Field of Classification Search**  
USPC ..... D24/216–217, 219, 222–226, 227, 231,  
D24/232, 107, 169, 186; D10/81;  
422/400–404, 408, 430, 68.1, 56, 69,  
422/500; 435/287.1, 287.3, 287.4, 288.1,  
435/288.3, 288.7, 806

FIG. 1 is a perspective view of a recognition test strip;  
FIG. 2 is a front view thereof;  
FIG. 3 is right view thereof (the left view being a mirror  
image);  
FIG. 4 is an enlarged top plan view thereof (the opposite end  
view being a mirror image); and,  
FIG. 5 is an enlarged fragmentary rear view thereof.

See application file for complete search history.

The broken lines in all views are included for the purpose of  
illustrating portions of the recognition test strip that form no  
part of the claimed design.

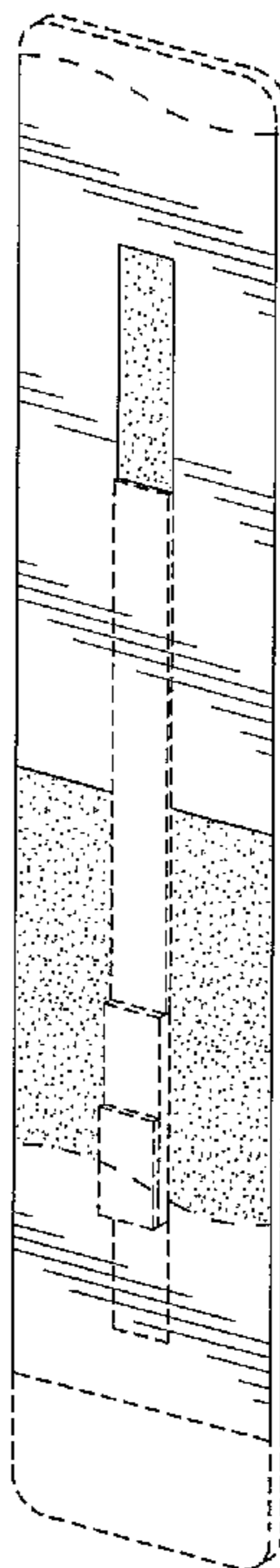
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The curved dashed lines in the drawing views are included to  
show the point at which the magnified view, FIG. 5, is cut and  
form no part of the claimed design.

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**1 Claim, 4 Drawing Sheets**



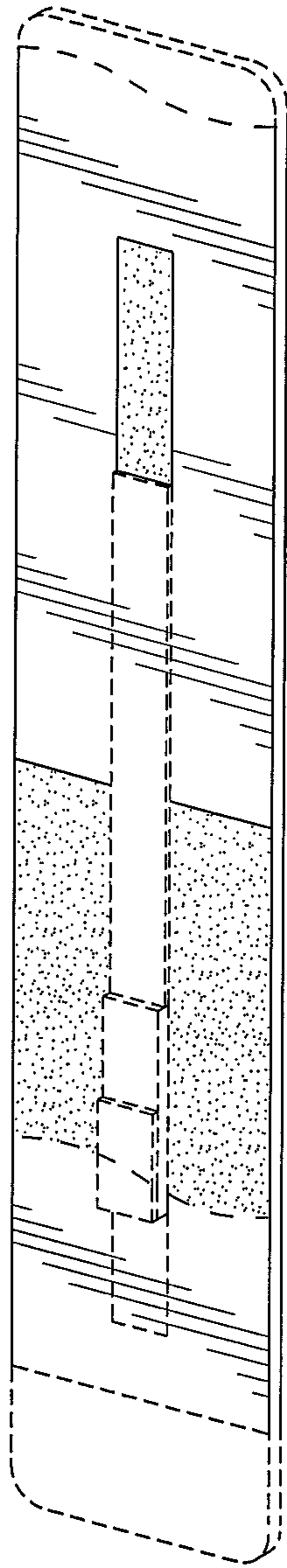


FIG. 1

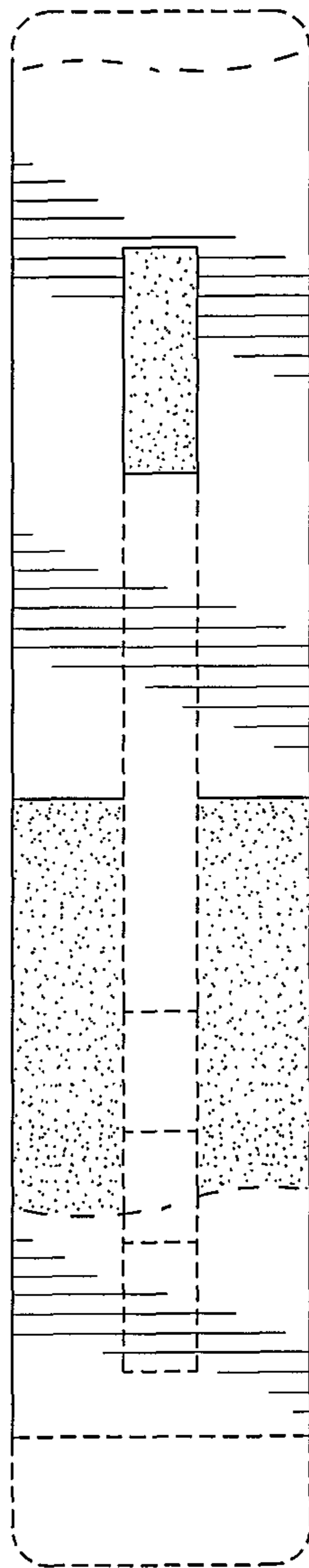


FIG. 2

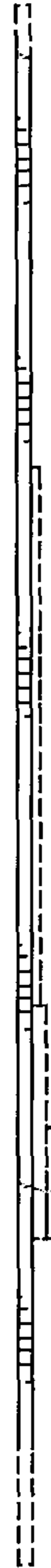


FIG. 3

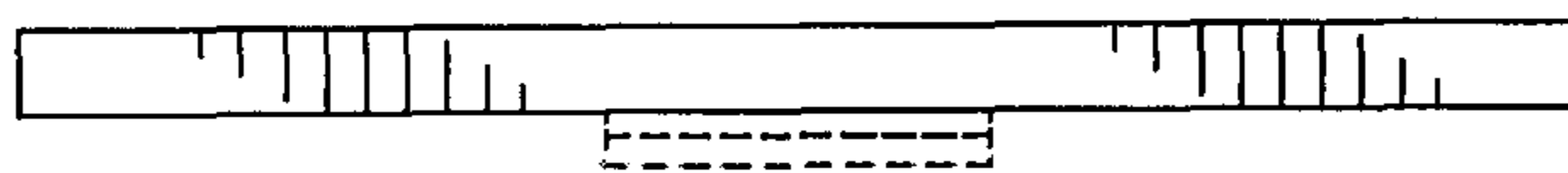


FIG. 4

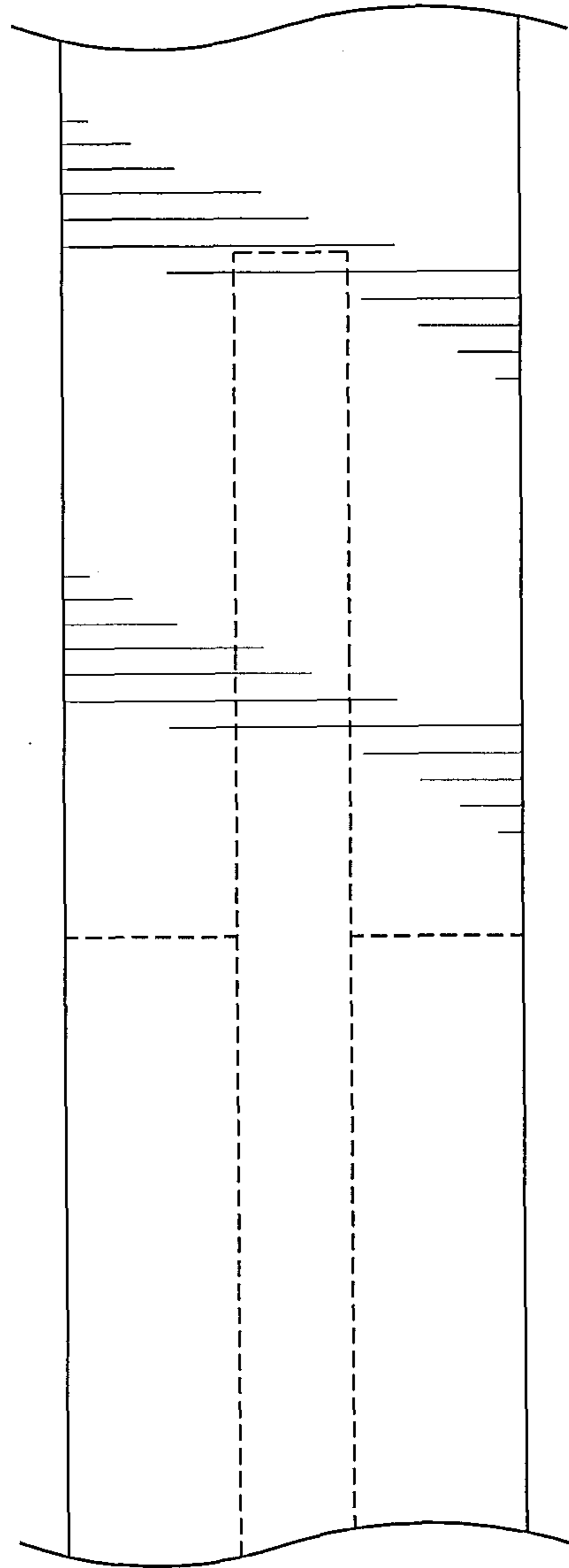


FIG. 5